## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10502512	TAKABAYASHI ET AL.
Examiner	Art Unit
Matin, Nurul M	2635

	SEARCHED				
Class	Subclass	Date	Examiner		
375	296, 224,232, 285,254	10/31/2006	Matin, Nurul M		

SEARCH NOTES					
Search Notes	Date	Examiner			
Consulted with Lin Ye for claim 2 and also searched for the double patenting.	10/31/2006	Matin, Nurul M			
Consulted with SPE Mohammad Ghayour about allowable claims 1-6	4/27/2007	Matin, Nurul M			
NPL and IEEE search is completed	4/27/2007	Matin, Nurul M			

INTERFERENCE SEARCH							
Class		Subclass	Date	Examiner			
455	126		4/27/2007	Matin, Nurul M			

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